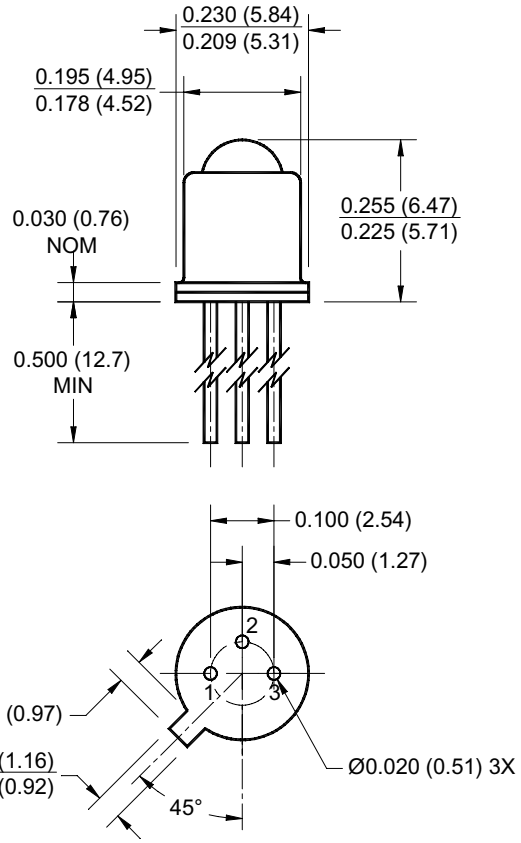
HERMETIC SILICON PHOTOTRANSISTOR

Part Nos. 08 L14G1 and 08 L14G2

Back to **Photo-Transistors/Diodes** *Main Page*

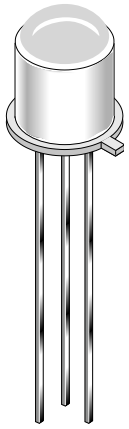
L14G1 L14G2 L14G3

PACKAGE DIMENSIONS

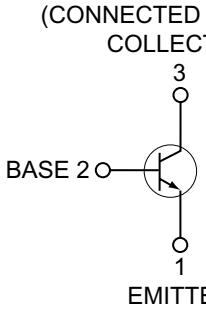


NOTES:

1. Dimensions for all drawings are in inches (mm).
2. Tolerance of ± .010 (.25) on all non-nominal dimensions unless otherwise specified.



SCHEMATIC



DESCRIPTION

The L14G1/L14G2/L14G3 are silicon phototransistors mounted in a narrow angle, TO-18 package.

FEATURES

- Hermetically sealed package
- Narrow reception angle

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ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise specified)

Parameter	Symbol	Rating	Unit
Operating Temperature	T_{OPR}	-65 to +125	°C
Storage Temperature	T_{STG}	-65 to +150	°C
Soldering Temperature (Iron)(3,4,5 and 6)	T_{SOL-I}	240 for 5 sec	°C
Soldering Temperature (Flow)(3,4 and 6)	T_{SOL-F}	260 for 10 sec	°C
Collector to Emitter Breakdown Voltage	V_{CEO}	45	V
Collector to Base Breakdown Voltage	V_{CBO}	45	V
Emitter to Base Breakdwon Voltage	V_{EBO}	5	V
Power Dissipation (T_A = 25°C)(1)	P_D	300	mW
Power Dissipation (T_C = 25°C)(2)	P_D	600	mW

NOTE:
1. Derate power dissipation linearly 3.00 mW/°C above 25°C ambient.
2. Derate power dissipation linearly 6.00 mW/°C above 25°C case.
3. RMA flux is recommended.
4. Methanol or isopropyl alcohols are recommended as cleaning agents.
5. Soldering iron tip 1/16" (1.6mm) minimum from housing.
6. As long as leads are not under any stress or spring tension.
7. Light source is a GaAs LED emitting light at a peak wavelength of 940 nm.
8. Figure 1 and figure 2 use light source of tungsten lamp at 2870°K color temperature. A GaAs source of 3.0 mW/cm^2 is approximately equivalent to a tungsten source, at 2870°K, of 10 mW/cm^2.

ELECTRICAL / OPTICAL CHARACTERISTICS (T_A =25°C) (All measurements made under pulse conditions)

PARAMETER	TEST CONDITIONS	SYMBOL	MIN	TYP	MAX	UNITS
Collector-Emitter Breakdown	I_C = 10 mA, Ee = 0	BV_{CEO}	45		—	V
Emitter-Base Breakdown	I_E = 100 µA, Ee = 0	BV_{EBO}	5.0		—	V
Collector-Base Breakdown	I_C = 100 µA, Ee = 0	BV_{CBO}	45		—	V
Collector-Emitter Leakage	V_{CE} = 10 V, Ee = 0	I_{CEO}	—		100	nA
Reception Angle at 1/2 Sensitivity		θ		±10		Degrees
On-State Collector Current L14G1	Ee = 0.5 mW/cm^2, V_{CE} = 5 V(7,8)	$I_{C(ON)}$	1.0		—	mA
On-State Collector Current L14G2	Ee = 0.5 mW/cm^2, V_{CE} = 5 V(7,8)	$I_{C(ON)}$	0.5			mA
On-State Collector Current L14G3	Ee = 0.5 mW/cm^2, V_{CE} = 5 V(7,8)	$I_{C(ON)}$	2.0			mA
Turn-On Time	I_C = 2 mA, V_{CC} = 10 V, R_L =100 Ω	t_{on}		8		µs
Turn-Off Time	I_C = 2 mA, V_{CC} = 10 V, R_L =100 Ω	t_{off}		7		µs
Saturation Voltage	I_C = 1.0 mA, Ee = 3.0 mW/cm^2(7,8)	$V_{CE(SAT)}$	—		0.40	V

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Figure 1. Light Current vs. Collector to Emitter Voltage

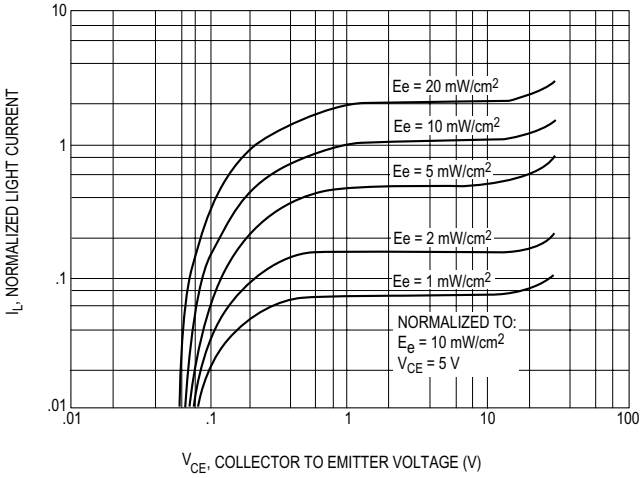


Figure 2. Light Current vs. Temperature

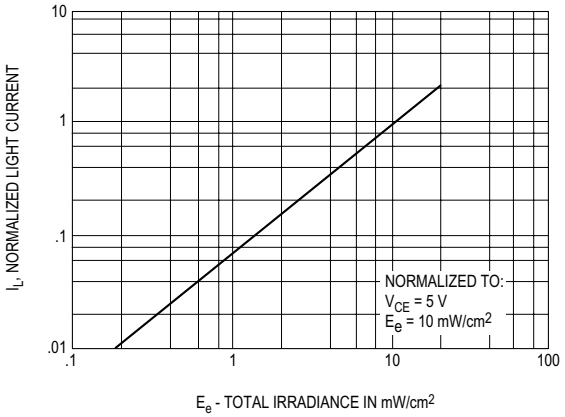


Figure 3. Normalized Light Current vs. Temperature

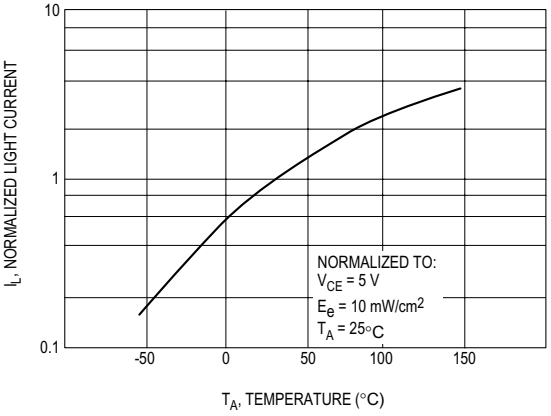


Figure 4. Switching Times vs. Output Current

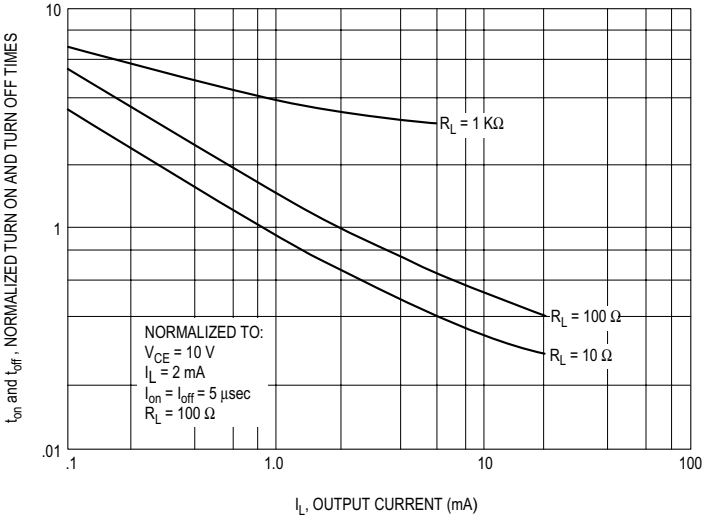


Figure 5. Dark Current and Temperature

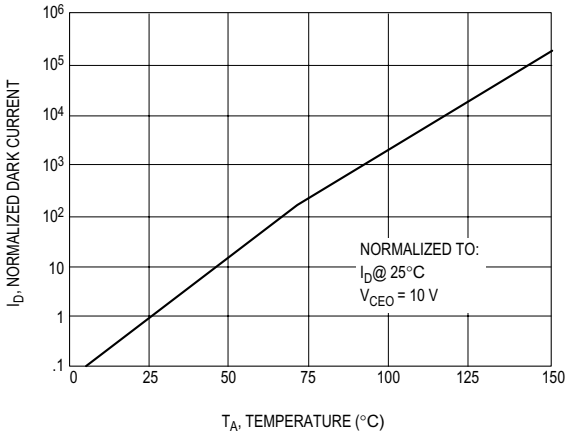
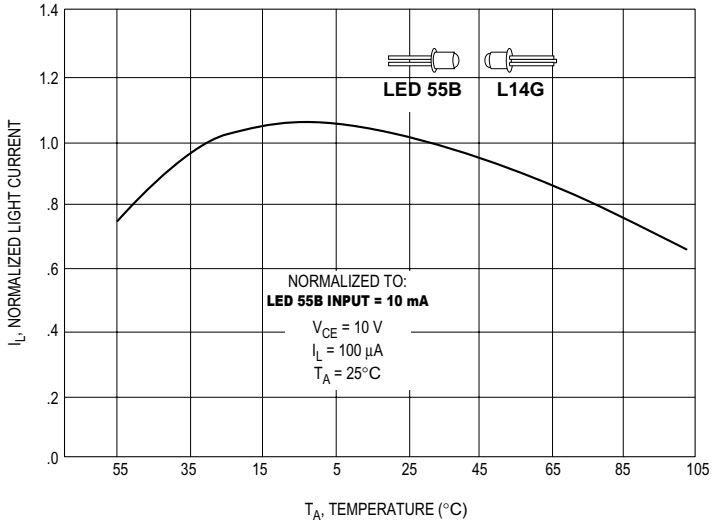


Figure 6. Normalized Light Current vs. Temperature Both Emitter (LED 55B) and Detector (L14G) at Same Temperature



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